

## UNITED STATE DEPARTMENT OF COMMERCE Patent and Trademark Office

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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR			ATTO	DRNEY DOCKET NO.
9/498,336	02/04/00	SHIELDS		J	5235	2-372
_		r Marian Zalanan	Ī	EXAMINER		
IM22/0323 CDermott Will & Emery			FEREZ RAMOS, V			
500 13th Street N W			ART	UNIT	PAPER NUMBER	
lashington DC 20005-3096		96		1765		3
				DATE M		23/01

Please find below and/or attached an Office communication concerning this application or proceeding.

**Commissioner of Patents and Trademarks** 

			Applicant(s)			
- h. V	Application No.	7 1				
	09/498,336		SHIELDS ET AL.			
Action Summary	Examiner			1		
Office Action Summary	1	s	1765	dress		
The MAILING DATE of this communication app	Vanessa Fores	with the c	orrespondence at	Julese		
DATE of this communication app	ears on the covers			•		
Period for Reply  A SHORTENED STATUTORY PERIOD FOR REPL THE MAILING DATE OF THIS COMMUNICATION THE MAILING DATE OF THIS COMMUNICATION  Extensions of time may be available under the provisions of 37 CFR 1  Extensions of time may be available under the provisions of 37 CFR 1  If the period for reply specified above is less than thirty (30) days, a recommunication of the period for reply specified above, the maximum statutory perion of NO period for reply is specified above, the maximum statutory perion of the period for reply within the set or extended period for reply will, by state that the period for reply within the set or extended period for reply will, by state that the period for the period for the period for the period for reply within the set or extended period for reply will, by state that the period for the period for the period for reply within the set or extended period for reply will, by state the period for th	ply within the statutory minimum d will apply and will expire SIX (6 ute, cause the application to bec ling date of this communication,	N NACHTHS IT	om the mailing date of the	mely is communication.		
status  1) Responsive to communication(s) filed on		١.				
1) Responsive to community 2b)	This action is non-fina	 nal matter	s, prosecution as	to the ments is		
1) Responsive to communication(s) filed on 2  2a) This action is <b>FINAL</b> . 2b) Since this application is in condition for all closed in accordance with the practice un	owance except for form der Ex parte Quayle, 1	935 C.D.	11, 453 O.G. <sup>213</sup>	•		
Disposition of Claims	ation.					
Disposition of Claims  4) Claim(s) 1-20 is/are pending in the application of the above claim(s) is/are with the application of the above claim(s).	bdrawn from considera	ition.				
4a) Of the above Claim(3)	Haram					
5) Claim(s) is/are allowed.						
- 1. :(a) 1-20 is/are rejection.	`			v.		
6) Claim(s) is/are objected to.	u roquire	ment.				
7) Claim(s) is/are objected to.  8) Claims are subject to restriction	and/or election require					
8) Claims are subject						
Application Papers	vaminer.			•		
	ingted to by the Exami	ner.				
The drawing(s) filed on is/are of	is: a) app	roved b)[	] disapproveu.			
9) The specification is objected  10) The drawing(s) filed on is/are ob  11) The proposed drawing correction filed	on					
11) The proposed drawing correction in the 12) The oath or declaration is objected to	by the Examinor.					
12) The oath of decide as			2 440(a)-(d) Of	(f).		
Priority under 35 U.S.C. § 119	or foreign priority unde	r 35 U.S.C	), 9 (15(a) (a)			
Acknowledgment is made of a claim	0115					
Priority under 35 U.S.C. § 119  13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).  a) All b) Some * c) None of:  1. Certified copies of the priority documents have been received in Application No.						
Certified copies of the priority of	Jocuments have been	received i	n Application No.			
- used conies of the priority						
2. Certified copies  3. Copies of the certified copies application from the Interr	of the priority document	Rule 17.2(8	a)).			
application from the Interr	on for a list of the certifi	ed copies	U.C.C. & 119(e).			
3. Copies of the certified copies application from the Interrespond to the See the attached detailed Office actions and its made of a claim.	m for domestic priority	under 35	0,5.0.8			
* See the attached detailed Office action  * Acknowledgement is made of a claim	•••					
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Attachment(s)		19) 📙 N	terview Summary (1 ) otice of Informal Pater	Ut Application		
15) Notice of References Cited (PTO-892)  Notice of Draftsperson's Patent Drawing Review  Notice of Draftsperson's Patent Drawing Review  Province of Draftsperson's Patent Drawing Review	v (PTO-948)	20) 🔲 O	ther:			
<ul> <li>15) ∑ Notice of References of the Notice of Draftsperson's Patent Drawing Review</li> <li>16) ∑ Notice of Draftsperson's Patent Drawing Review</li> <li>17) ∑ Information Disclosure Statement(s) (PTO-144)</li> </ul>	9) Papel No(3/			•- :		
17) 🖾 Iniointation	Office Action Summ	ary				



Application/Control Number: 09/498,336

Art Unit: 1765

## **DETAILED ACTION**

## Specification

1.	It is requested that Applicant updates the	following	"Related Applica	ation Information	ı" on
page 1	, lines 1-5: "U.S. Patent Application Ser	ial No	filed on		

## Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 3. Claims 1-20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kepler (U.S. 6046104) in view of Solis (U.S. 5851302).

In regard to claims 1, 12 and 14, Kepler discloses a method comprising: forming a first dielectric layer on a substrate (col. 1, line 47); forming a first patterned conductive layer having gaps, the first patterned conductive layer comprising a first conductive feature (col. 1, lines 45-51 and col. 2, line 9); depositing a dielectric gap fill layer to fill the gaps (col. 1, lines 52-59); depositing a second dielectric layer on the first patterned conductive layer (col. 1, lines 62-64). Furthermore, Kepler discloses the formation of a photoresist mask (col. 1, lines 34-37) and the formation of a through-hole or via in the second dielectric layer exposing the upper surface of the first conductive feature.

Kepler does not disclose removing the photoresist mask and cleaning the through hole with a plasma containing CF4 and H2O.

Application/Control Number: 09/498,336

Art Unit: 1765

Solis discloses a process for forming via contact holes, including a step of removing the photoresist with a plasma comprising CF4 and H2O (col. 2, lines 45-64).

It is the Examiner's position that it would have been obvious to one skilled in the art at the time of the invention to modify Kepler by removing the photoresist layer with a plasma comprising CF4 and H2O, as per Solis, because, as stated by Solis, "an etch gas mixture comprising CF4 and H2O exhibits very aggressive ashrate of photoresist" (col. 2, lines 6-9), which is very desirable during semiconductor, manufacturing.

In regard to claims 2, 4-11 and 15-20, it is the Examiner's position that the variation of process parameters is obvious to one skilled in the art with the purpose of establishing the best process mode.

In regard to claim 3, Kepler discloses the use of HSQ (col. 2, lines 60-67).

In regard to claim 13, Kepler discloses the formation of borderless vias (col. 9, lines 5 and 64).

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Vanessa Perez-Ramos whose telephone number is 703-306-5510. The examiner can normally be reached on Mon-Fri 8:30am-5:00pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Benjamin Utech can be reached on 703-308-3836. The fax phone numbers for the organization where this application or proceeding is assigned are 703-305-7718 for regular communications and 703-305-3599 for After Final communications.

Art Unit: 1765

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-306-5665.

Vanessa Perez-Ramos Examiner Art Unit 1765 Page 4

VPR March 21, 2001

> BENJAMIN L. UTECH SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 1700

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